

2SJ451

Silicon P Channel MOS FET

Application

Low frequency power switching

Features

- Low on-resistance.
- Low drive power
- 2.5V gate drive device.
- Small package (MPAK).

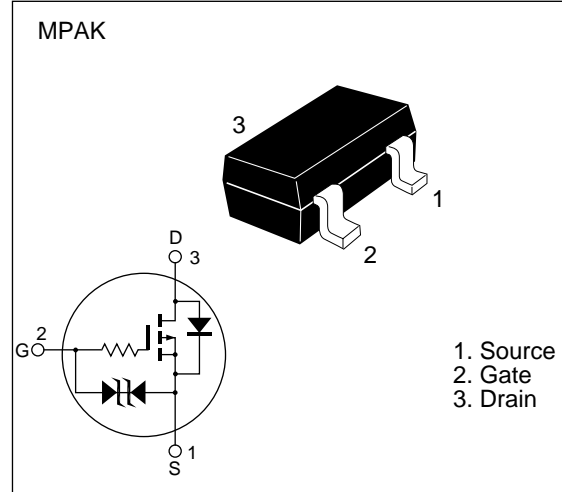


Table 1 Absolute Maximum Ratings (Ta = 25°C)

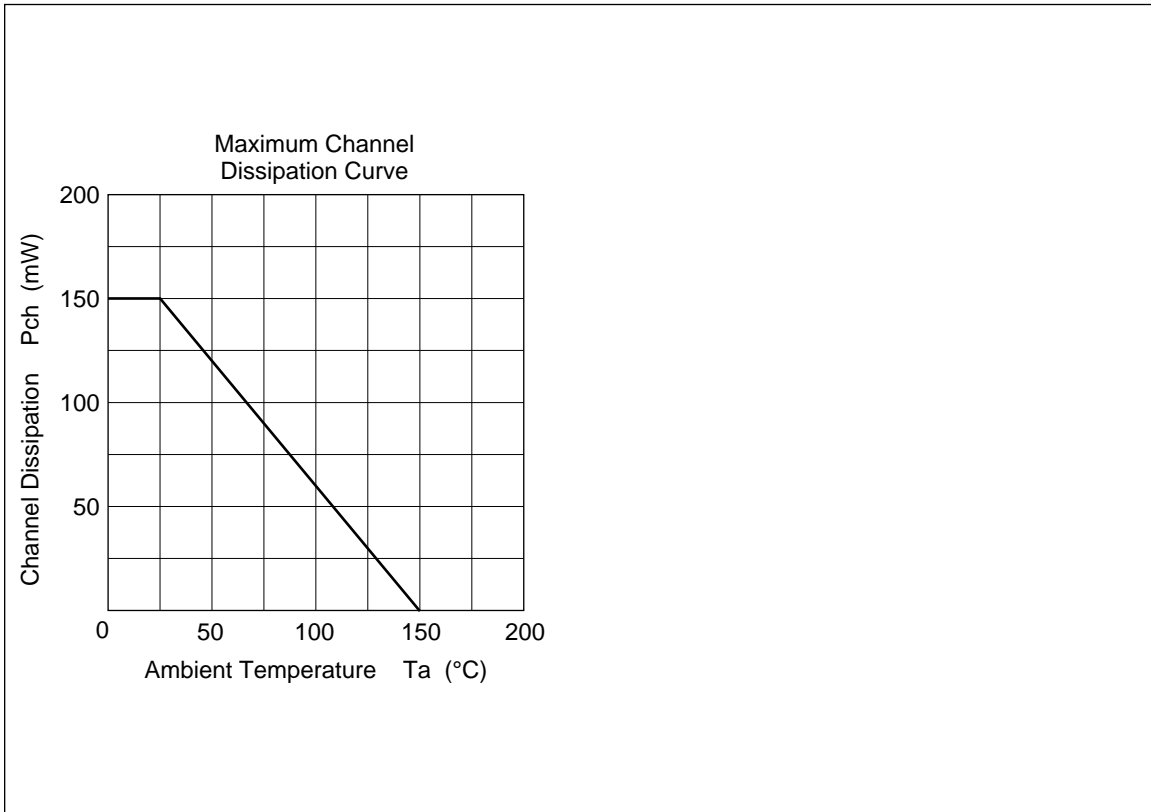
Item	Symbol	Ratings	Unit
Drain to source voltage	V_{DSS}	-20	V
Gate to source voltage	V_{GSS}	± 20	V
Drain current	I_D	-0.2	A
Drain peak current	$I_{D(pulse)}^*$	-0.4	A
Channel dissipation	P_{ch}^{**}	150	mW
Channel temperature	T_{ch}	150	°C
Storage temperature	T_{stg}	-55 to +150	°C

* $PW \leq 10 \mu s$, duty cycle $\leq 1\%$
 Marking is "ZK-".

Table 2 Electrical Characteristics (Ta = 25°C)

Item	Symbol	Min	Typ	Max	Unit	Test conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	-20	—	—	V	$I_D = -100 \mu A, V_{GS} = 0$
Gate to source breakdown voltage	$V_{(BR)GSS}$	± 20	—	—	V	$I_G = \pm 100 \mu A, V_{DS} = 0$
Zero gate voltage drain current	I_{DSS}	—	—	-1.0	μA	$V_{DS} = -16 V, V_{GS} = 0$
Gate to source leak current	I_{GSS}	—	—	± 2.0	μA	$V_{GS} = \pm 16 V, V_{DS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	-0.5	—	-1.5	V	$I_D = -10 \mu A, V_{DS} = -5 V$
Static drain to source on state resistance	$R_{DS(on)1}$	—	2.3	3.5	Ω	$I_D = -100 mA$ $V_{GS} = -4 V^*$
Static drain to source on state resistance	$R_{DS(on)2}$	—	5.0	9.0	Ω	$I_D = -40 mA$ $V_{GS} = -2.5 V^*$
Foward transfer admittance	$ y_{fs} $	0.13	0.23	—	S	$I_D = -100 mA$ $V_{DS} = -10 V$
Input capacitance	C_{iss}	—	2.4	—	pF	$V_{DS} = -10 V$
Output capacitance	C_{oss}	—	31	—	pF	$V_{GS} = 0$
Reverse transfer capacitance	C_{rss}	—	0.6	—	pF	$f = 1 MHz$
Turn-on delay time	$t_{d(on)}$	—	0.17	—	μs	$V_{GS} = -10 V, I_D = -0.1 A$
Rise time	t_r	—	0.68	—	μs	$R_L = 100 \Omega$
Turn-off delay time	$t_{d(off)}$	—	3.0	—	μs	
Fall time	t_f	—	2.8	—	μs	

* Pulse Test



Package Dimensions

Unit : mm

